

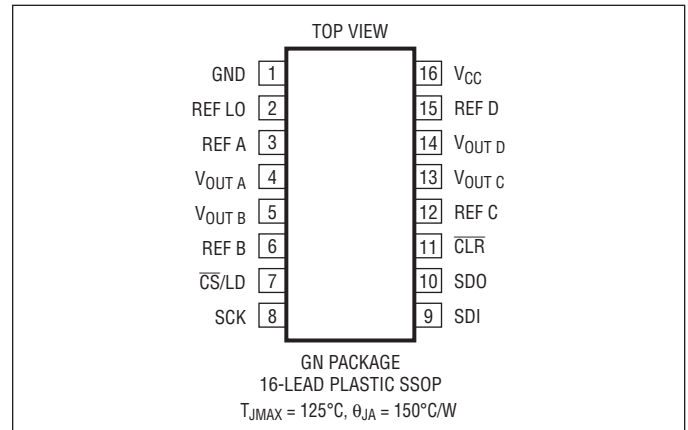
LTC2604/LTC2614/LTC2624

ABSOLUTE MAXIMUM RATINGS

(Note 1)

Any Pin to GND	–0.3V to 6V
Any Pin to V_{CC}	–6V to 0.3V
Maximum Junction Temperature	125°C
Operating Temperature Range	
LTC2604C/LTC2614C/LTC2624C	0°C to 70°C
LTC2604C-1/LTC2614C-1/	
LTC2624C-1	0°C to 70°C
LTC2604I/LTC2614I/LTC2624I	–40°C to 85°C
LTC2604I-1/LTC2614I-1/	
LTC2624I-1	–40°C to 85°C
Storage Temperature Range	–65°C to 150°C
Lead Temperature (Soldering, 10 sec)	300°C

PIN CONFIGURATION



ORDER INFORMATION

LEAD FREE FINISH	TAPE AND REEL	PART MARKING	PACKAGE DESCRIPTION	TEMPERATURE RANGE
LTC2604CGN#PBF	LTC2604CGN#TRPBF	2604	16-Lead Narrow SSOP Package	0°C to 70°C
LTC2604CGN-1#PBF	LTC2604CGN-1#TRPBF	26041	16-Lead Narrow SSOP Package	0°C to 70°C
LTC2604IGN#PBF	LTC2604IGN#TRPBF	2604I	16-Lead Narrow SSOP Package	–40°C to 85°C
LTC2604IGN-1#PBF	LTC2604IGN-1#TRPBF	2604I1	16-Lead Narrow SSOP Package	–40°C to 85°C
LTC2614CGN#PBF	LTC2614CGN#TRPBF	2614	16-Lead Narrow SSOP Package	0°C to 70°C
LTC2614CGN-1#PBF	LTC2614CGN-1#TRPBF	26141	16-Lead Narrow SSOP Package	0°C to 70°C
LTC2614IGN#PBF	LTC2614IGN#TRPBF	2614I	16-Lead Narrow SSOP Package	–40°C to 85°C
LTC2614IGN-1#PBF	LTC2614IGN-1#TRPBF	2614I1	16-Lead Narrow SSOP Package	–40°C to 85°C
LTC2624CGN#PBF	LTC2624CGN#TRPBF	2624	16-Lead Narrow SSOP Package	0°C to 70°C
LTC2624CGN-1#PBF	LTC2624CGN-1#TRPBF	26241	16-Lead Narrow SSOP Package	0°C to 70°C
LTC2624IGN#PBF	LTC2624IGN#TRPBF	2624I	16-Lead Narrow SSOP Package	–40°C to 85°C
LTC2624IGN-1#PBF	LTC2624IGN-1#TRPBF	2624I1	16-Lead Narrow SSOP Package	–40°C to 85°C

Consult LTC Marketing for parts specified with wider operating temperature ranges.

Consult LTC Marketing for information on non-standard lead based finish parts.

For more information on lead free part marking, go to: <http://www.linear.com/leadfree/>

For more information on tape and reel specifications, go to: <http://www.linear.com/tapeandreel/>

ELECTRICAL CHARACTERISTICS

The ● denotes specifications which apply over the full operating temperature range, otherwise specifications are at $T_A = 25^\circ\text{C}$. REF A = REF B = REF C = REF D = 4.096V ($V_{CC} = 5\text{V}$), REF A = REF B = REF C = REF D = 2.048V ($V_{CC} = 2.5\text{V}$), REF LO = 0V, V_{OUT} unloaded, unless otherwise noted. (Note 10)

SYMBOL	PARAMETER	CONDITIONS	LTC2624/LTC2624-1			LTC2614/LTC2614-1			LTC2604/LTC2604-1			UNITS
			MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
DC Performance												
	Resolution		●	12		14		16				Bits
	Monotonicity	(Note 2)	●	12		14		16				Bits
DNL	Differential Nonlinearity	(Note 2)	●	±0.5		±1		±1				LSB
INL	Integral Nonlinearity	(Note 2)	●	±0.9 ±4		±4 ±16		±14 ±64				LSB

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SYMBOL	PARAMETER	CONDITIONS		LTC2624/LTC2624-1			LTC2614/LTC2614-1			LTC2604/LTC2604-1			UNITS
				MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
	Load Regulation	V _{REF} = V _{CC} = 5V, Midscale	●	0.025	0.125	0.1	0.5	0.3	2	LSB/mA			
		I _{OUT} = 0mA to 15mA Sourcing											
		I _{OUT} = 0mA to 15mA Sinking	●	0.025	0.125	0.1	0.5	0.3	2	LSB/mA			
		V _{REF} = V _{CC} = 2.5V, Midscale	●	0.05	0.25	0.2	1	0.7	4	LSB/mA			
I _{OUT} = 0mA to 7.5mA Sourcing													
ZSE	Zero-Scale Error	I _{OUT} = 0mA to 7.5mA Sinking	●	1.5	9	1.5	9	1.5	9	mV			
		I _{OUT} = 0mA to 7.5mA Sinking											
		V _{OS}	Offset Error	(Note 7)	●	±1.5	±9	±1.5	±9	±1.5	±9	mV	
			V _{OS} Temperature Coefficient			±5		±5		±5		µV/°C	
GE	Gain Error		●	±0.1	±0.7	±0.1	±0.7	±0.1	±0.7	%FSR			
	Gain Temperature Coefficient			±5		±5		±5		ppm/°C			

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SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
PSR	Power Supply Rejection	$V_{CC} = 5\text{V} \pm 10\%$ $V_{CC} = 3\text{V} \pm 10\%$		-80 -80		dB dB
R_{OUT}	DC Output Impedance	$V_{REF} = V_{CC} = 5\text{V}$, Midscale; $-15\text{mA} \leq I_{OUT} \leq 15\text{mA}$ $V_{REF} = V_{CC} = 2.5\text{V}$, Midscale; $-7.5\text{mA} \leq I_{OUT} \leq 7.5\text{mA}$	● ●	0.025 0.030	0.15 0.15	Ω Ω
	DC Crosstalk (Note 4)	Due to Full Scale Output Change (Note 5) Due to Load Current Change Due to Powering Down (per Channel)		±5 ±1 ±3.5		μV $\mu\text{V}/\text{mA}$ μV
I_{SC}	Short-Circuit Output Current	$V_{CC} = 5.5\text{V}$, $V_{REF} = 5.5\text{V}$ Code: Zero Scale; Forcing Output to V_{CC} Code: Full Scale; Forcing Output to GND	● ●	15 15	34 36 60 60	mA mA
		$V_{CC} = 2.5\text{V}$, $V_{REF} = 2.5\text{V}$ Code: Zero Scale; Forcing Output to V_{CC} Code: Full Scale; Forcing Output to GND	● ●	7.5 7.5	18 24 50 50	mA mA

Reference Input

	Input Voltage Range		●	0	V_{CC}	μA
	Resistance	Normal Mode	●	88	128 160	k Ω
	Capacitance			14		pF
I_{REF}	Reference Current, Power Down Mode	All DACs Powered Down	●	0.001	1	μA

Power Supply

V_{CC}	Positive Supply Voltage	For Specified Performance	●	2.5	5.5	V
I_{CC}	Supply Current	$V_{CC} = 5\text{V}$ (Note 3) $V_{CC} = 3\text{V}$ (Note 3) All DACs Powered Down (Note 3) $V_{CC} = 5\text{V}$ All DACs Powered Down (Note 3) $V_{CC} = 3\text{V}$	● ● ● ●	1.3 1 0.35 0.10	2 1.6 1 1	mA mA μA μA

Digital I/O

V_{IH}	Digital Input High Voltage	$V_{CC} = 2.5\text{V}$ to 5.5V $V_{CC} = 2.5\text{V}$ to 3.6V	● ●	2.4 2.0		V V
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LTC2604/LTC2614/LTC2624

ELECTRICAL CHARACTERISTICS

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SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
V_{IL}	Digital Input Low Voltage	$V_{CC} = 4.5\text{V to } 5.5\text{V}$ $V_{CC} = 2.5\text{V to } 5.5\text{V}$	●		0.8 0.6	V V
V_{OH}	Digital Output High Voltage	Load Current = $-100\mu\text{A}$	●	$V_{CC} - 0.4$		V
V_{OL}	Digital Output Low Voltage	Load Current = $+100\mu\text{A}$	●		0.4	V
I_{LK}	Digital Input Leakage	$V_{IN} = \text{GND to } V_{CC}$	●		± 1	μA
C_{IN}	Digital Input Capacitance	(Note 6)	●		8	pF

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SYMBOL	PARAMETER	CONDITIONS	LTC2624/LTC2624-1			LTC2614/LTC2614-1			LTC2604/LTC2604-1			UNITS
			MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	

AC Performance

t_s	Settling Time (Note 8)	$\pm 0.024\%$ ($\pm 1\text{LSB}$ at 12 Bits) $\pm 0.006\%$ ($\pm 1\text{LSB}$ at 14 Bits) $\pm 0.0015\%$ ($\pm 1\text{LSB}$ at 16 Bits)		7		7	9		7	9	10	μs μs μs
	Settling Time for 1LSB Step (Note 9)	$\pm 0.024\%$ ($\pm 1\text{LSB}$ at 12 Bits) $\pm 0.006\%$ ($\pm 1\text{LSB}$ at 14 Bits) $\pm 0.0015\%$ ($\pm 1\text{LSB}$ at 16 Bits)		2.7		2.7	4.8		2.7	4.8	5.2	μs μs μs
	Voltage Output Slew Rate			0.80		0.80			0.80			V/ μs
	Capacitive Load Driving			1000		1000			1000			pF
	Glitch Impulse	At Midscale Transition		12		12			12			nV • s
	Multiplying Bandwidth			180		180			180			kHz
e_n	Output Voltage Noise Density	At $f = 1\text{kHz}$ At $f = 10\text{kHz}$		120 100		120 100			120 100			$\text{nV}/\sqrt{\text{Hz}}$ $\text{nV}/\sqrt{\text{Hz}}$
	Output Voltage Noise	0.1Hz to 10Hz		15		15			15			μV_{P-P}

TIMING CHARACTERISTICS

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SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
$V_{CC} = 2.5\text{V to } 5.5\text{V}$						
t_1	SDI Valid to SCK Setup		●	4		ns
t_2	SDI Valid to SCK Hold		●	4		ns
t_3	SCK High Time		●	9		ns
t_4	SCK Low Time		●	9		ns
t_5	$\overline{\text{CS}}/\text{LD}$ Pulse Width		●	10		ns
t_6	LSB SCK High to $\overline{\text{CS}}/\text{LD}$ High		●	7		ns
t_7	$\overline{\text{CS}}/\text{LD}$ Low to SCK High		●	7		ns
t_8	SDO Propagation Delay from SCK Falling Edge	$C_{LOAD} = 10\text{pF}$ $V_{CC} = 4.5\text{V to } 5.5\text{V}$ $V_{CC} = 2.5\text{V to } 5.5\text{V}$	● ●		20 45	ns ns
t_9	$\overline{\text{CLR}}$ Pulse Width		●	20		ns

2604fd

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SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
t_{10}	$\overline{\text{CS}}/\text{LD}$ High to SCK Positive Edge		7			ns
	SCK Frequency	50% Duty Cycle			50	MHz

Note 1: Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. Exposure to any Absolute Maximum Rating condition for extended periods may affect device reliability and lifetime.

Note 2: Linearity and monotonicity are defined from code k_L to code $2^N - 1$, where N is the resolution and k_L is given by $k_L = 0.016(2^N/V_{REF})$, rounded to the nearest whole code. For $V_{REF} = 4.096\text{V}$ and $N = 16$, $k_L = 256$, linearity is defined from code 256 to code 65,535.

Note 3: Digital inputs at 0V or V_{CC} .

Note 4: DC crosstalk is measured with $V_{CC} = 5\text{V}$ and $V_{REF} = 4.096\text{V}$, with the measured DAC at midscale, unless otherwise noted.

Note 5: $R_L = 2\text{k}\Omega$ to GND or V_{CC} .

Note 6: Guaranteed by design and not production tested.

Note 7: Inferred from measurement at code 256 (LTC2604), code 64 (LTC2614) or code 16 (LTC2624), and at full scale.

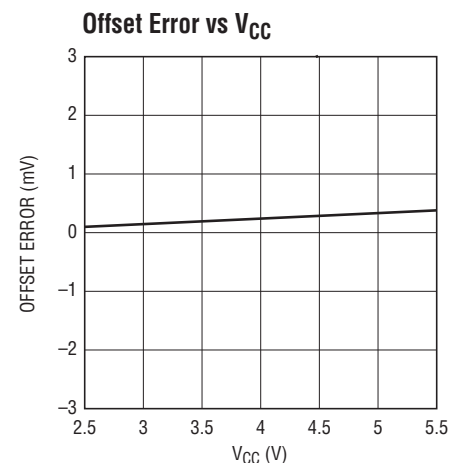
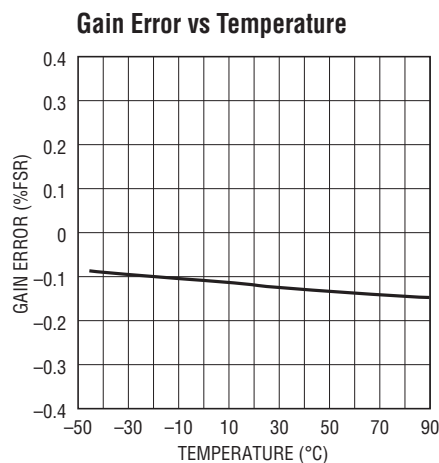
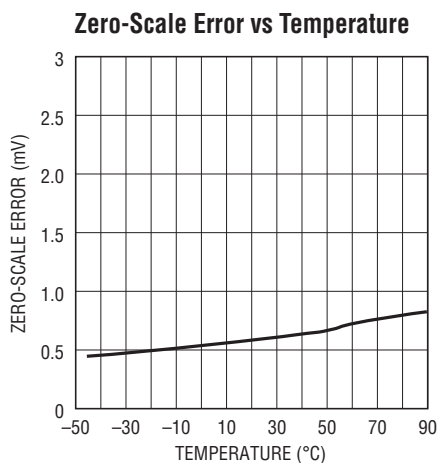
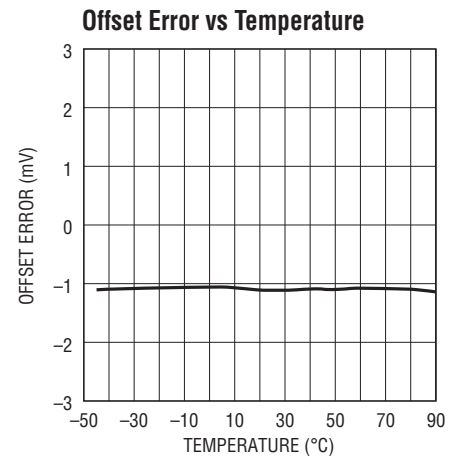
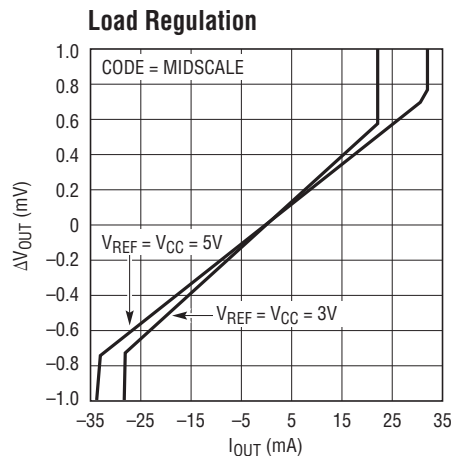
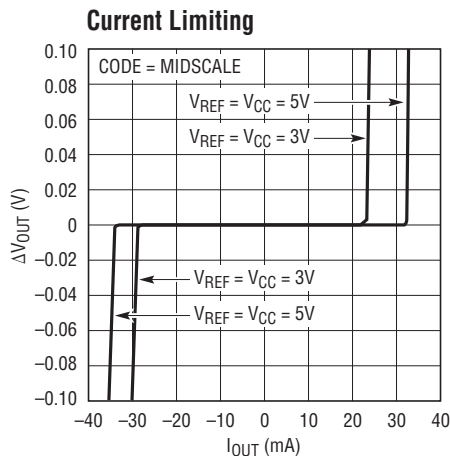
Note 8: $V_{CC} = 5\text{V}$, $V_{REF} = 4.096\text{V}$. DAC is stepped 1/4 scale to 3/4 scale and 3/4 scale to 1/4 scale. Load is 2k in parallel with 200pF to GND.

Note 9: $V_{CC} = 5\text{V}$, $V_{REF} = 4.096\text{V}$. DAC is stepped 1LSB between half scale and half scale -1. Load is 2k in parallel with 200pF to GND.

Note 10: These specifications apply to LTC2604/LTC2604-1, LTC2614/LTC2614-1, LTC2624/LTC2624-1.

TYPICAL PERFORMANCE CHARACTERISTICS

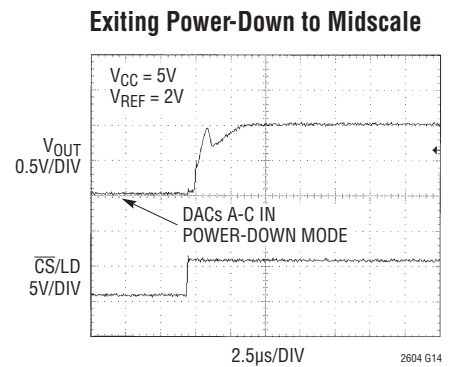
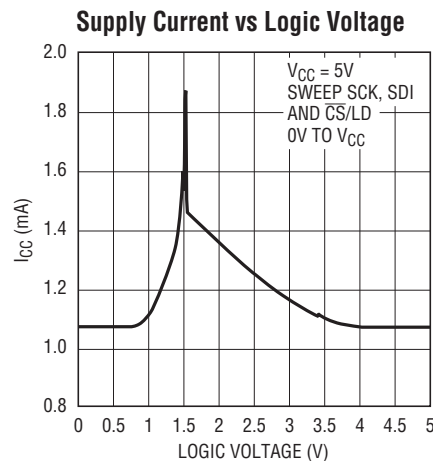
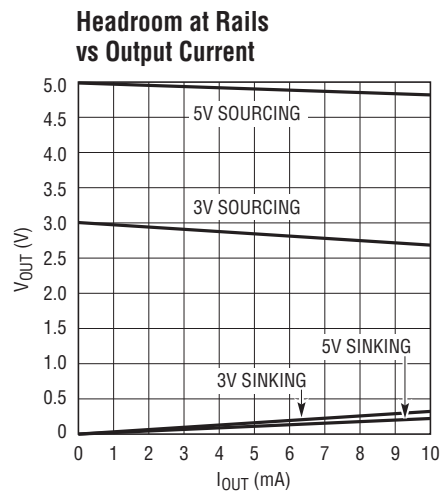
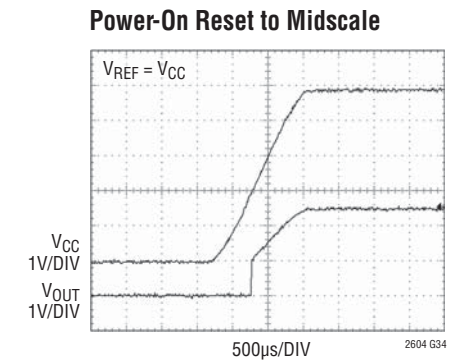
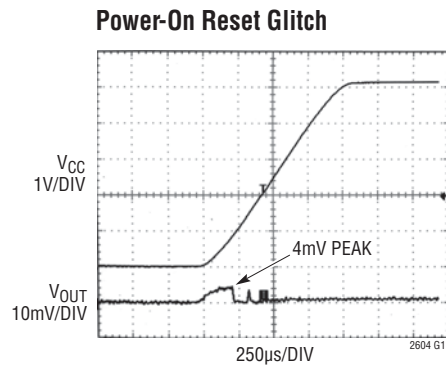
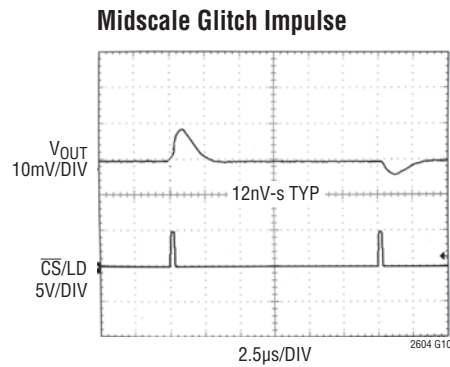
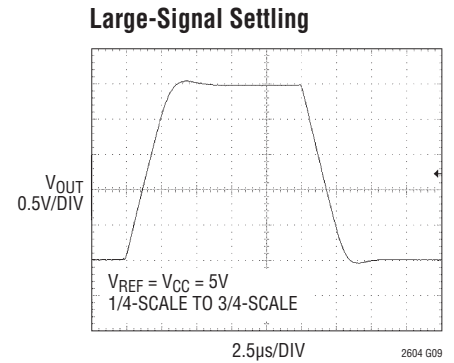
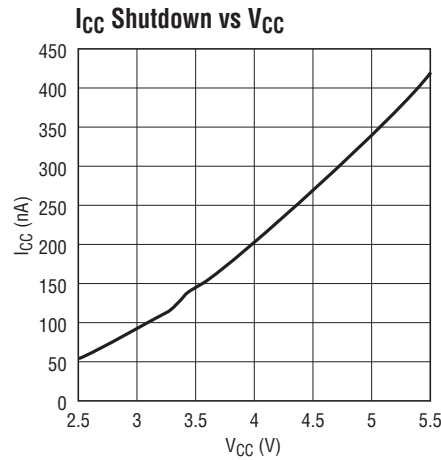
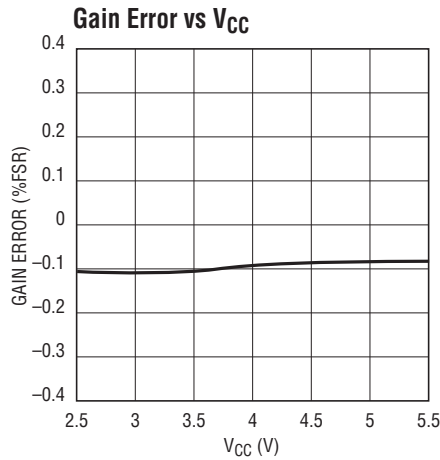
(LTC2604/LTC2604-1, LTC2614/LTC2614-1, LTC2624/LTC2624-1)



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TYPICAL PERFORMANCE CHARACTERISTICS

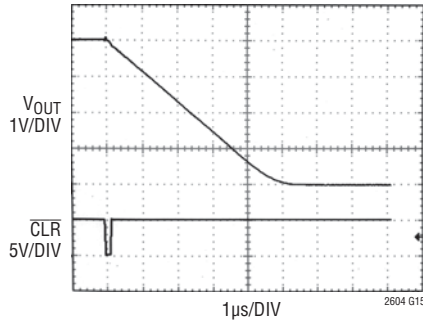
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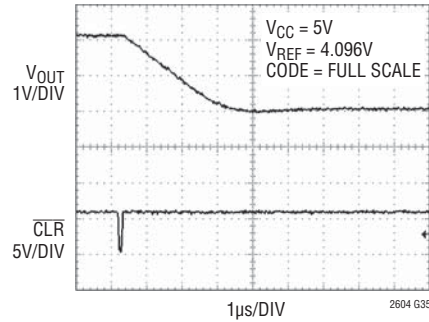
TYPICAL PERFORMANCE CHARACTERISTICS

(LTC2604/LTC2604-1, LTC2614/LTC2614-1, LTC2624/LTC2624-1)

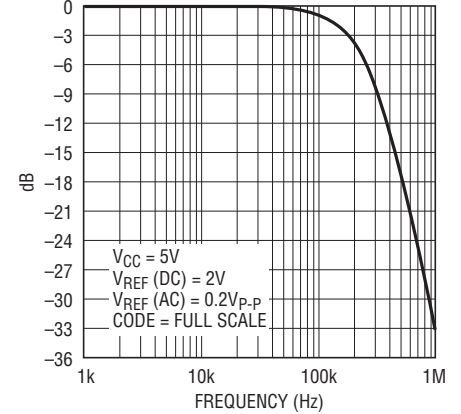
Hardware CLR



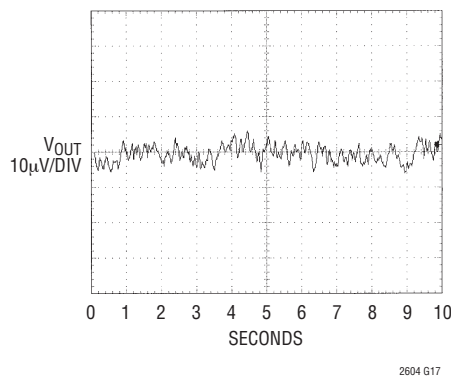
Hardware CLR to Midscale



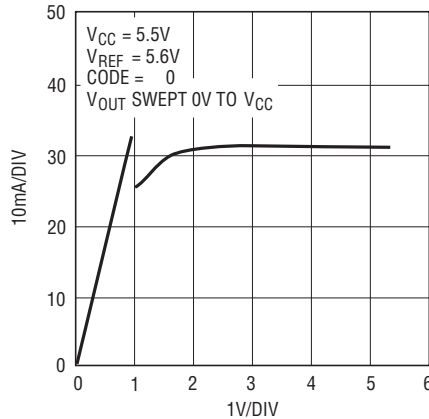
Multiplying Frequency Response



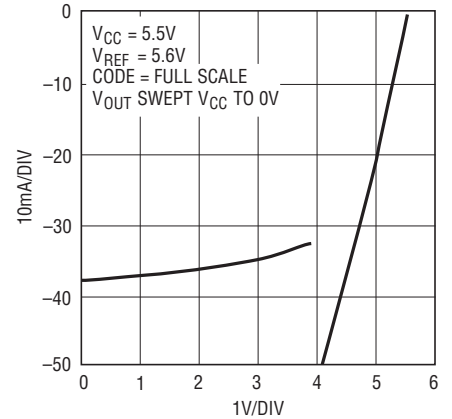
Output Voltage Noise, 0.1Hz to 10Hz



Short-Circuit Output Current vs V_{OUT} (Sinking)

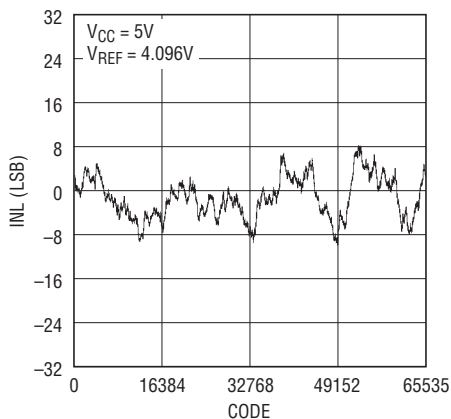


Short-Circuit Output Current vs V_{OUT} (Sourcing)

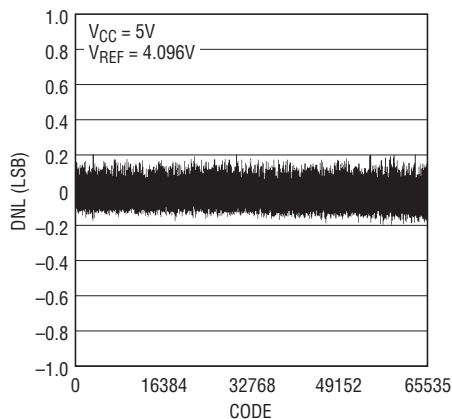


(LTC2604/LTC2604-1)

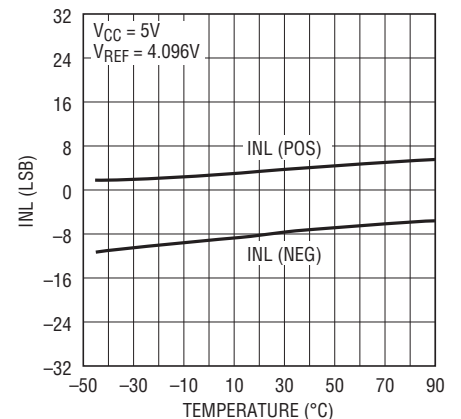
Integral Nonlinearity (INL)



Differential Nonlinearity (DNL)

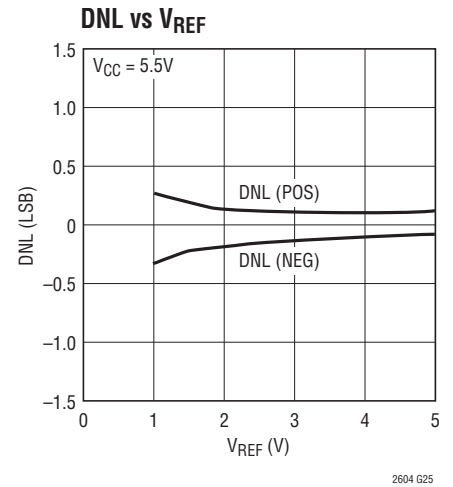
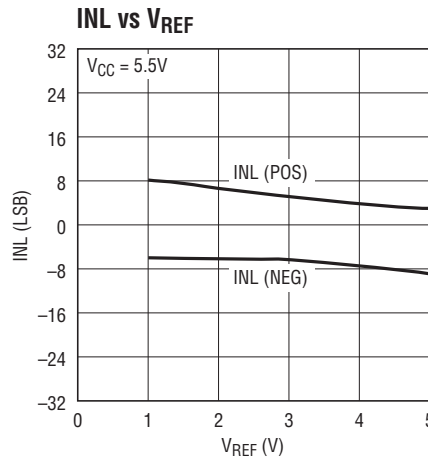
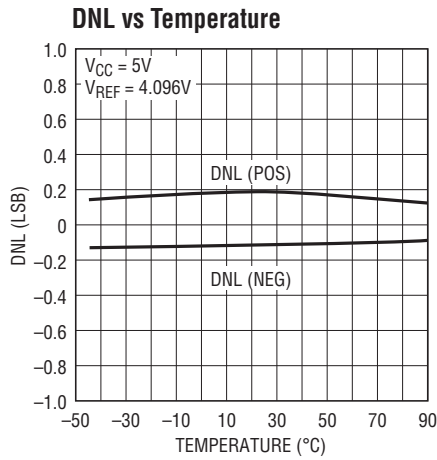


INL vs Temperature

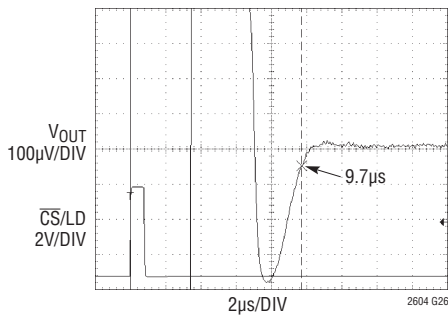


TYPICAL PERFORMANCE CHARACTERISTICS

(LTC2604/LTC2604-1)

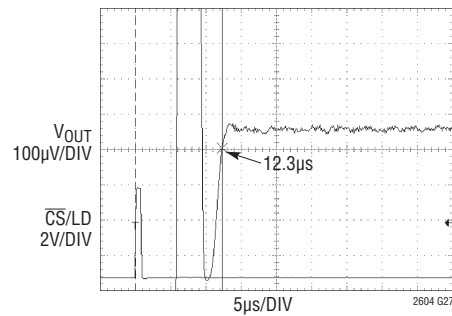


Settling to $\pm 1LSB$



$V_{CC} = 5V$, $V_{REF} = 4.096V$
1/4-SCALE TO 3/4-SCALE STEP
 $R_L = 2k$, $C_L = 200pF$
AVERAGE OF 2048 EVENTS

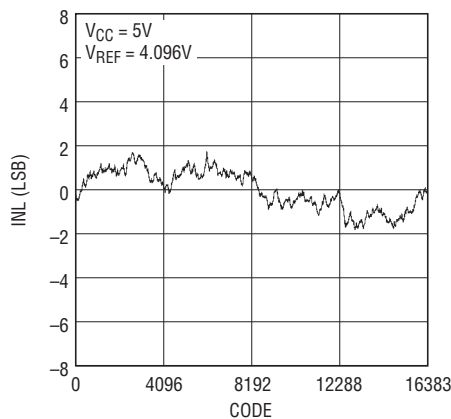
Settling of Full-Scale Step



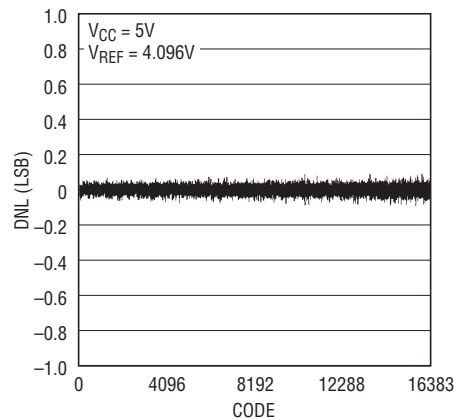
$V_{CC} = 5V$, $V_{REF} = 4.096V$
CODE 512 TO 65535 STEP
AVERAGE OF 2048 EVENTS
SETTLING TO $\pm 1LSB$

(LTC2614/LTC2614-1)

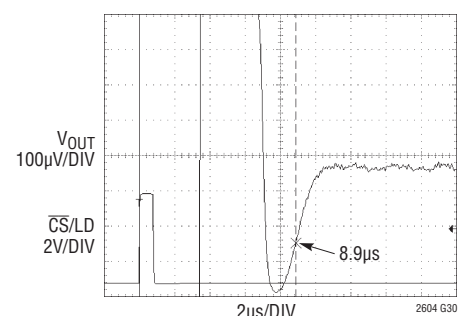
Integral Nonlinearity (INL)



Differential Nonlinearity (DNL)



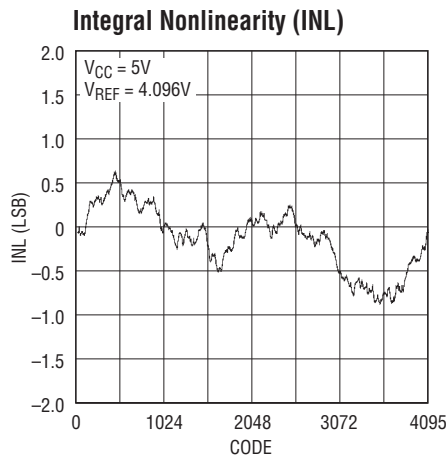
Settling to $\pm 1LSB$



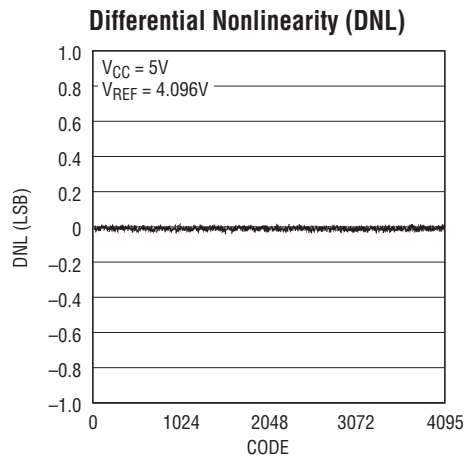
$V_{CC} = 5V$, $V_{REF} = 4.096V$
1/4-SCALE TO 3/4-SCALE STEP
 $R_L = 2k$, $C_L = 200pF$
AVERAGE OF 2048 EVENTS

TYPICAL PERFORMANCE CHARACTERISTICS

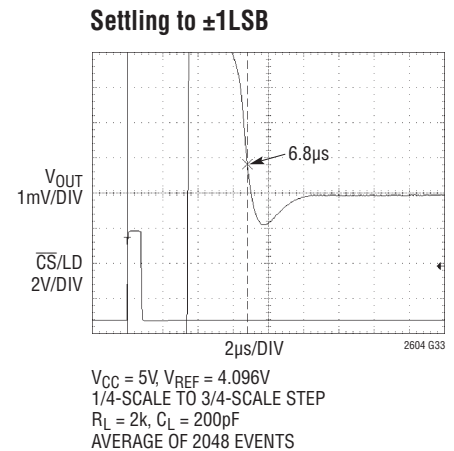
(LTC2624/LTC2624-1)



2604 G31



2604 G32



2604 G33

PIN FUNCTIONS

GND (Pin 1): Analog Ground.

REF LO (Pin 2): Reference Low. The voltage at this pin sets the zero scale (ZS) voltage of all DACs. This pin can be raised up to 1V above ground at $V_{CC} = 5V$ or 100mV above ground at $V_{CC} = 3V$.

REF A, REF B, REF C, REF D (Pins 3, 6, 12, 15): Reference Voltage Inputs for each DAC. REF x sets the full scale voltage of the DACs. $0V \leq REF\ x \leq V_{CC}$.

V_{OUTA} to V_{OUTD} (Pins 4, 5, 13, 14): DAC Analog Voltage Outputs. The output range is from REF LO to REF x.

$\overline{CS}/LD$ (Pin 7): Serial Interface Chip Select/Load Input. When $\overline{CS}/LD$ is low, SCK is enabled for shifting data on SDI into the register. When $\overline{CS}/LD$ is taken high, SCK is disabled and the specified command (see Table 1) is executed.

SCK (Pin 8): Serial Interface Clock Input. CMOS and TTL compatible.

SDI (Pin 9): Serial Interface Data Input. Data is applied to SDI for transfer to the device at the rising edge of SCK.

The LTC2604/LTC2604-1, LTC2614/LTC2614-1, LTC2624/LTC2624-1 accept input word lengths of either 24 or 32 bits.

SDO (Pin 10): Serial Interface Data Output. This pin is used for daisy-chain operation. The serial output of the shift register appears at the SDO pin. The data transferred to the device via the SDI pin is delayed 32 SCK rising edges before being output at the next falling edge. SDO is an active output and does not go high impedance, even when $\overline{CS}/LD$ is taken to a logic high level.

$\overline{CLR}$ (Pin 11): Asynchronous Clear Input. A logic low at this level-triggered input clears all registers and causes the DAC voltage outputs to drop to 0V for the LTC2604/LTC2614/LTC2624. A logic low at this input sets all registers to midscale code and causes the DAC voltage outputs to go to midscale for the LTC2604-1/LTC2614-1/LTC2624-1. CMOS and TTL compatible.

V_{CC} (Pin 16): Supply Voltage Input. $2.5V \leq V_{CC} \leq 5.5V$.

OPERATION

Power Supply Sequencing

The voltage at REF (Pins 3, 6, 12 and 15) should be kept within the range $-0.3V \leq \text{REF} \leq V_{CC} + 0.3V$ (see Absolute Maximum Ratings). Particular care should be taken to observe these limits during power supply turn-on and turn-off sequences, when the voltage at V_{CC} (Pin 16) is in transition.

Transfer Function

The digital-to-analog transfer function is

$$V_{\text{OUT(IDEAL)}} = \left(\frac{k}{2^N} \right) [\text{REF} \times - \text{REFLO}] + \text{REFLO}$$

where k is the decimal equivalent of the binary DAC input code, N is the resolution and REF x is the voltage at REF A, REF B, REF C and REF D (Pins 3, 6, 12 and 15).

Serial Interface

The $\overline{\text{CS/LD}}$ input is level triggered. When this input is taken low, it acts as a chip-select signal, powering-on the SDI and SCK buffers and enabling the input shift register. Data (SDI input) is transferred at the next 24 rising SCK edges. The 4-bit command, C3-C0, is loaded first; then the 4-bit DAC address, A3-A0; and finally the 16-bit data word. The data word comprises the 16-, 14- or 12-bit input code, ordered MSB-to-LSB, followed by 0, 2 or 4 don't-care bits

Table 1.

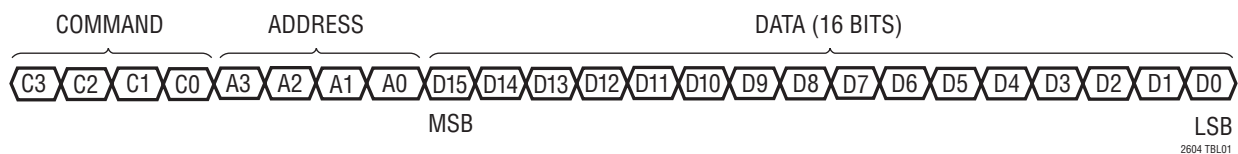
COMMAND*				
C3	C2	C1	C0	
0	0	0	0	Write to Input Register n
0	0	0	1	Update (Power Up) DAC Register n
0	0	1	0	Write to Input Register n, Update (Power Up) All n
0	0	1	1	Write to and Update (Power Up) n
0	1	0	0	Power Down n
1	1	1	1	No Operation
ADDRESS (n)*				
A3	A2	A1	A0	
0	0	0	0	DAC A
0	0	0	1	DAC B
0	0	1	0	DAC C
0	0	1	1	DAC D
1	1	1	1	All DACs

*Command and address codes not shown are reserved and should not be used.

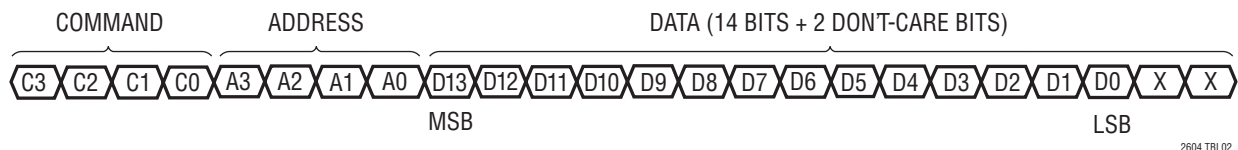
(LTC2604, LTC2614 and LTC2624 respectively). Data can only be transferred to the device when the $\overline{\text{CS/LD}}$ signal is low. The rising edge of $\overline{\text{CS/LD}}$ ends the data transfer and causes the device to carry out the action specified in the 24-bit input word. The complete sequence is shown in Figure 2a.

The command (C3-C0) and address (A3-A0) assignments are shown in Table 1. The first four commands in the table consist of write and update operations. A write operation loads a 16-bit data word from the 32-bit shift register into the input register of the selected DAC, n. An update

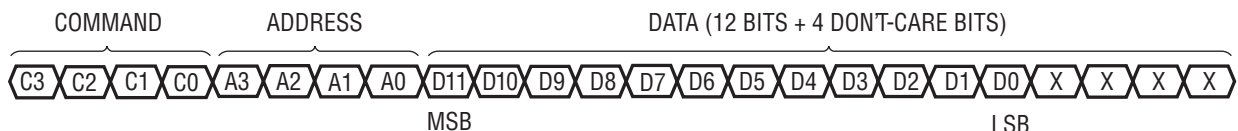
INPUT WORD (LTC2604)



INPUT WORD (LTC2614)



INPUT WORD (LTC2624)



OPERATION

operation copies the data word from the input register to the DAC register. Once copied into the DAC register, the data word becomes the active 16-, 14- or 12-bit input code, and is converted to an analog voltage at the DAC output. The update operation also powers up the selected DAC if it had been in power-down mode. The data path and registers are shown in the block diagram.

While the minimum input word is 24 bits, it may optionally be extended to 32 bits. To use the 32-bit word width, 8 don't-care bits are transferred to the device first, followed by the 24-bit word as just described. Figure 2b shows the 32-bit sequence. The 32-bit word is required for daisy-chain operation, and is also available to accommodate microprocessors which have a minimum word width of 16 bits (2 bytes).

Daisy-Chain Operation

The serial output of the shift register appears at the SDO pin. Data transferred to the device from the SDI input is delayed 32 SCK rising edges before being output at the next SCK falling edge.

The SDO output can be used to facilitate control of multiple serial devices from a single 3-wire serial port (i.e., SCK, SDI and $\overline{\text{CS}}/\text{LD}$). Such a "daisy-chain" series is configured by connecting SDO of each upstream device to SDI of the next device in the chain. The shift registers of the devices are thus connected in series, effectively forming a single input shift register which extends through the entire chain. Because of this, the devices can be addressed and controlled individually by simply concatenating their input words; the first instruction addresses the last device in the chain and so forth. The SCK and $\overline{\text{CS}}/\text{LD}$ signals are common to all devices in the series.

In use, $\overline{\text{CS}}/\text{LD}$ is first taken low. Then the concatenated input data is transferred to the chain, using SDI of the first device as the data input. When the data transfer is complete, $\overline{\text{CS}}/\text{LD}$ is taken high, completing the instruction sequence for all devices simultaneously. A single device can be controlled by using the no-operation command (1111) for the other devices in the chain.

Power-Down Mode

For power-constrained applications, power-down mode can be used to reduce the supply current whenever less than four outputs are needed. When in power-down, the buffer amplifiers, bias circuits and reference inputs are disabled, and draw essentially zero current. The DAC outputs are put into a high-impedance state, and the output pins are passively pulled to ground through individual 90k resistors. Input- and DAC-register contents are not disturbed during power-down.

Any channel or combination of channels can be put into power-down mode by using command 0100_b in combination with the appropriate DAC address, (n). The 16-bit data word is ignored. The supply current is reduced by approximately 1/4 for each DAC powered down. The effective resistance at REF x (pins 3, 6, 12 and 15) are at high-impedance input (typically > 1G Ω) when the corresponding DACs are powered down.

Normal operation can be resumed by executing any command which includes a DAC update, as shown in Table 1. The selected DAC is powered up as its voltage output is updated. When a DAC which is in a powered-down state is powered up and updated, normal settling is delayed. If less than four DACs are in a powered-down state prior to the update command, the power-up delay time is 5 μs . If on the other hand, all four DACs are powered down, then the main bias generation circuit block has been automatically shut down in addition to the individual DAC amplifiers and reference inputs. In this case, the power up delay time is 12 μs (for $V_{\text{CC}} = 5\text{V}$) or 30 μs (for $V_{\text{CC}} = 3\text{V}$).

Voltage Outputs

Each of the four rail-to-rail amplifiers contained in these parts has guaranteed load regulation when sourcing or sinking up to 15mA at 5V (7.5mA at 3V).

Load regulation is a measure of the amplifier's ability to maintain the rated voltage accuracy over a wide range of load conditions. The measured change in output voltage per milliampere of forced load current change is expressed in LSB/mA.

OPERATION

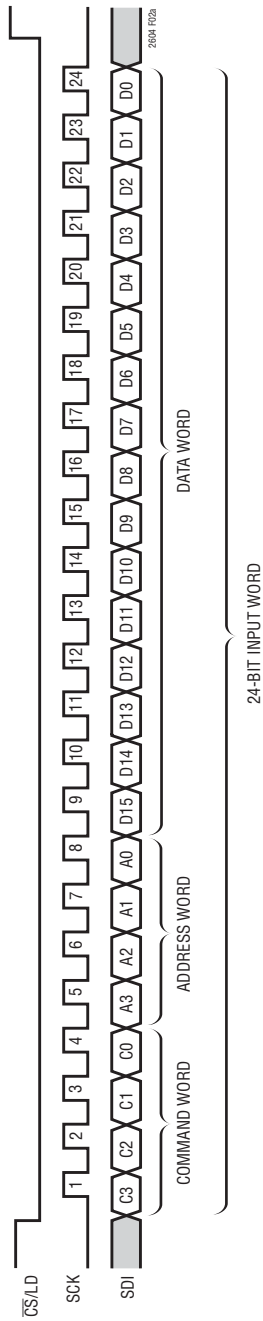


Figure 2a. LTC2604 24-Bit Load Sequence (Minimum Input Word)
 LTC2614 SDI Data Word: 14-Bit Input Code + 2 Don't Care Bits
 LTC2624 SDI Data Word: 12-Bit Input Code + 4 Don't Care Bits

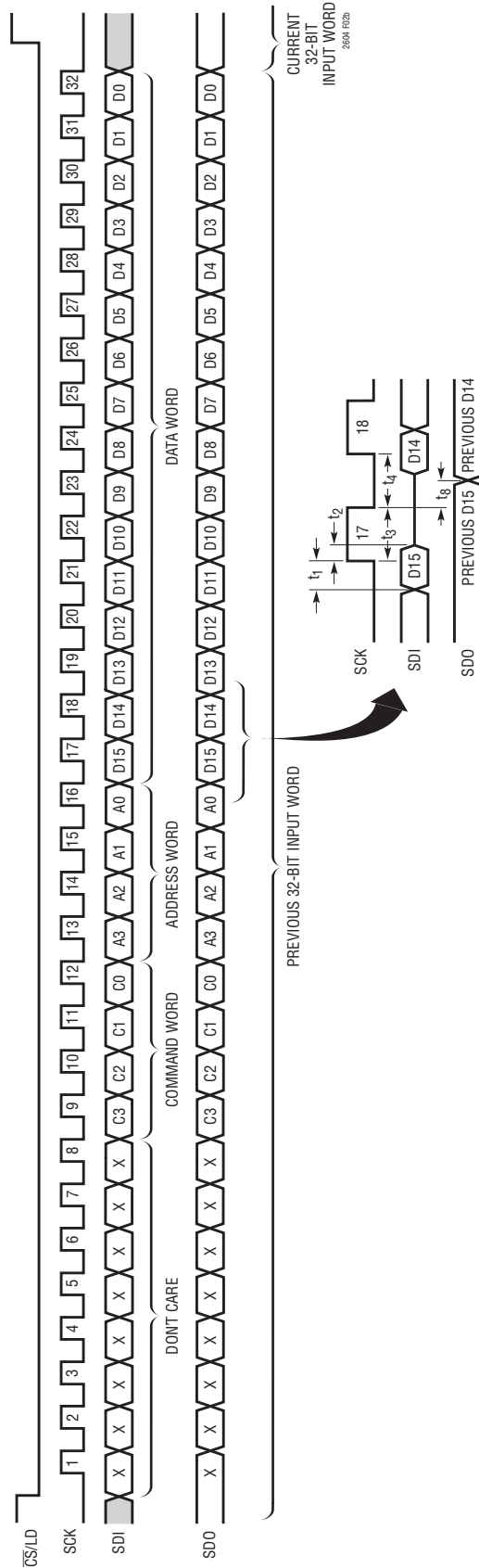


Figure 2b. LTC2604 32-Bit Load Sequence
 LTC2614 SDI/SDO Data Word: 14-Bit Input Code + 2 Don't Care Bits
 LTC2624 SDI/SDO Data Word: 12-Bit Input Code + 4 Don't Care Bits

OPERATION

DC output impedance is equivalent to load regulation, and may be derived from it by simply calculating a change in units from LSB/mA to Ohms. The amplifiers' DC output impedance is 0.025Ω when driving a load well away from the rails.

When drawing a load current from either rail, the output voltage headroom with respect to that rail is limited by the 30Ω typical channel resistance of the output devices; e.g., when sinking 1mA, the minimum output voltage = $30\Omega \cdot 1\text{mA} = 30\text{mV}$. See the graph Headroom at Rails vs Output Current in the Typical Performance Characteristics section.

The amplifiers are stable driving capacitive loads of up to 1000pF.

Board Layout

The excellent load regulation and DC crosstalk performance of these devices is achieved in part by keeping "signal" and "power" grounds separate.

The PC board should have separate areas for the analog and digital sections of the circuit. This keeps digital signals away from sensitive analog signals and facilitates the use of separate digital and analog ground planes which have minimal capacitive and resistive interaction with each other.

Digital and analog ground planes should be joined at only one point, establishing a system star ground as close to

the device's ground pin as possible. Ideally, the analog ground plane should be located on the component side of the board, and should be allowed to run under the part to shield it from noise. Analog ground should be a continuous and uninterrupted plane, except for necessary lead pads and vias, with signal traces on another layer.

The GND pin functions as a return path for power supply currents in the device and should be connected to analog ground. Resistance from the GND pin to system star ground should be as low as possible. When a zero scale DAC output voltage of zero is desired, the REFLO pin (pin 2) should be connected to system star ground.

Rail-to-Rail Output Considerations

In any rail-to-rail voltage output device, the output is limited to voltages within the supply range.

Since the analog outputs of the device cannot go below ground, they may limit for the lowest codes as shown in Figure 3b. Similarly, limiting can occur near full scale when the REF pins are tied to V_{CC} . If $\text{REF } x = V_{CC}$ and the DAC full-scale error (FSE) is positive, the output for the highest codes limits at V_{CC} as shown in Figure 3c. No full-scale limiting can occur if $\text{REF } x$ is less than $V_{CC} - \text{FSE}$.

Offset and linearity are defined and tested over the region of the DAC transfer function where no output limiting can occur.

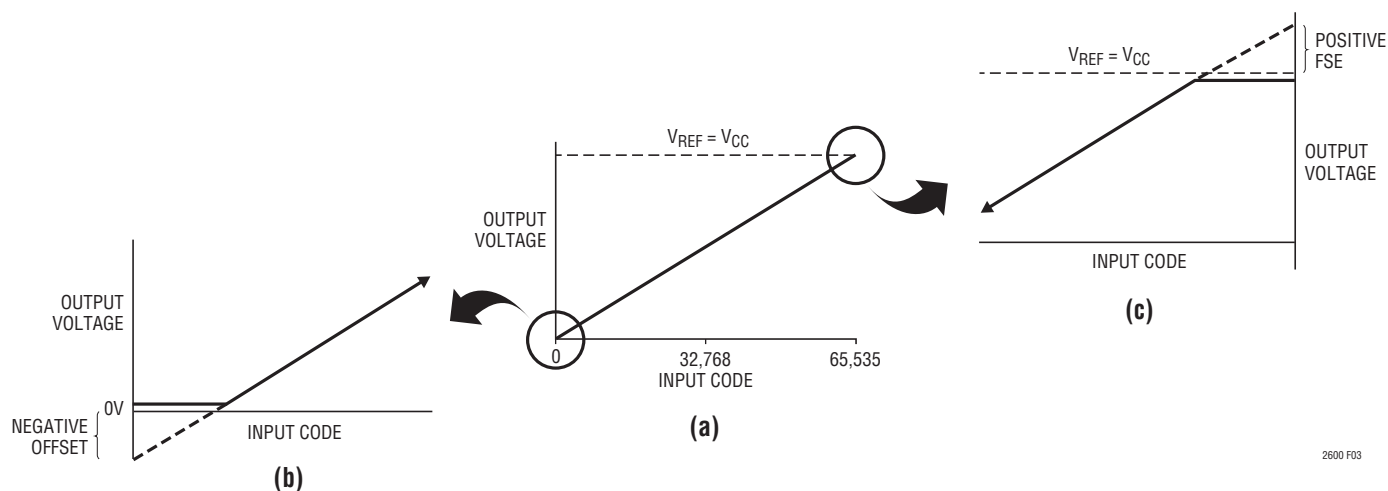


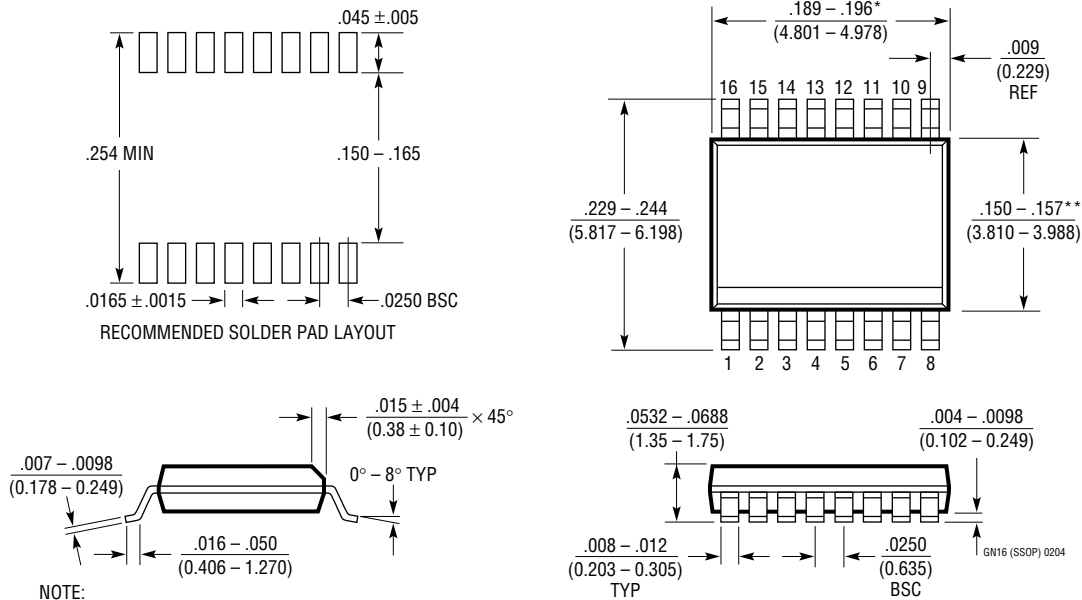
Figure 3. Effects of Rail-to-Rail Operation On a DAC Transfer Curve. (a) Overall Transfer Function (b) Effect of Negative Offset for Codes Near Zero Scale (c) Effect of Positive Full-Scale Error for Codes Near Full Scale

2600 F03

2604fd

PACKAGE DESCRIPTION

GN Package 16-Lead Plastic SSOP (Narrow .150 Inch) (Reference LTC DWG # 05-08-1641)



TYPICAL APPLICATION

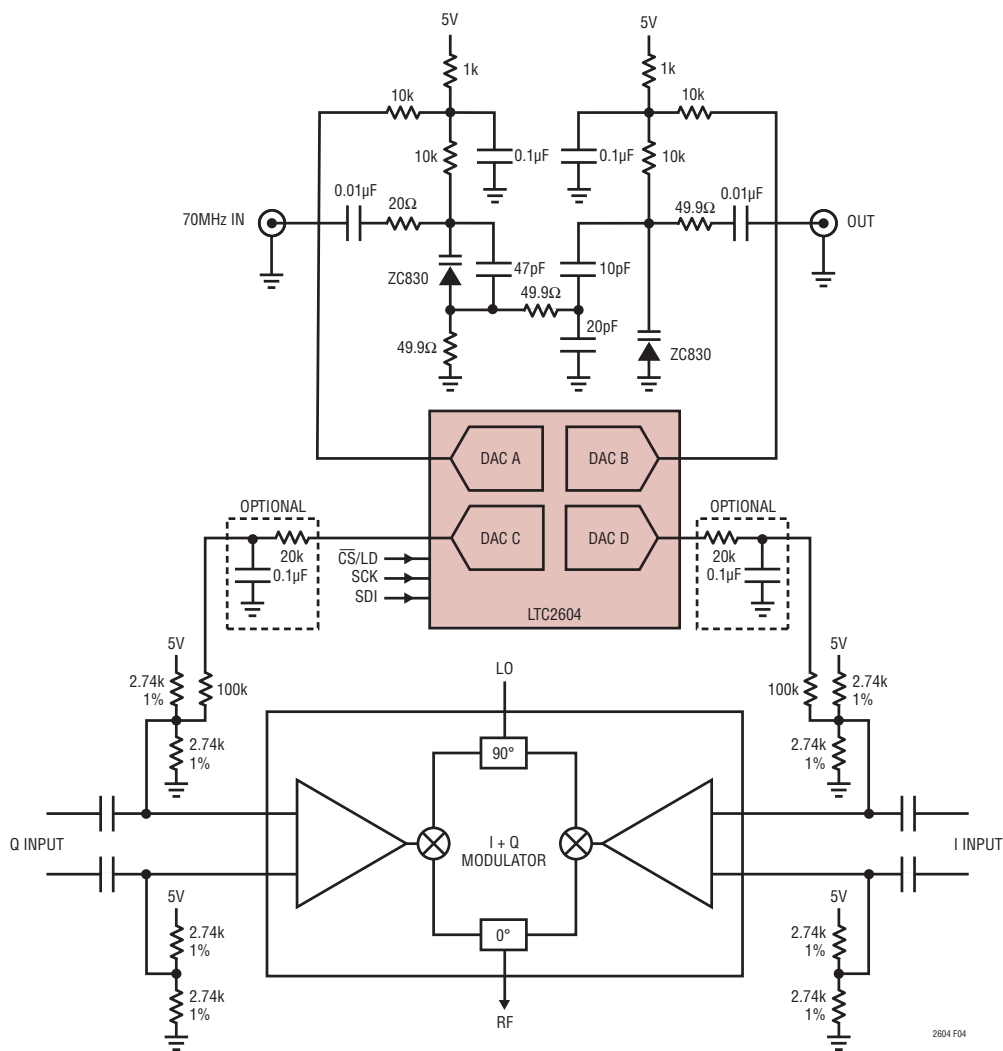


Figure 4. Using DAC A and DAC B for Nearly Continuous Attenuation Control and DAC C and DAC D to Trim for Minimum LO Feedthrough in a Mixer

RELATED PARTS

PART NUMBER	DESCRIPTION	COMMENTS
LTC1458/LTC1458L	Quad 12-Bit Rail-to-Rail Output DACs with Added Functionality	LTC1458: $V_{CC} = 4.5V$ to $5.5V$, $V_{OUT} = 0V$ to $4.096V$ LTC1458L: $V_{CC} = 2.7V$ to $5.5V$, $V_{OUT} = 0V$ to $2.5V$
LTC1654	Dual 14-Bit Rail-to-Rail V_{OUT} DAC	Programmable Speed/Power
LTC1655/LTC1655L	Single 16-Bit V_{OUT} DAC with Serial Interface in SO-8	$V_{CC} = 5V(3V)$, Low Power, Deglitched
LTC1657/LTC1657L	Parallel 5V/3V 16-Bit V_{OUT} DAC	Low Power, Deglitched, Rail-to-Rail V_{OUT}
LTC1660/LTC1665	Octal 8-Bit/10-Bit V_{OUT} DAC in 16-Pin Narrow SSOP	$V_{CC} = 2.7V$ to $5.5V$, Micropower, Rail-to-Rail Output
LTC1821	Parallel 16-Bit Voltage Output DAC	Precision 16-Bit Settling in $2\mu s$ for 10V Step
LTC2600/LTC2610/LTC2620	Octal 16-Bit/14-Bit/12-Bit Rail-to-Rail DACs in 16-Lead SSOP	$250\mu A$ per DAC, $2.5V$ to $5.5V$ Supply Range
LTC2602/LTC2612/LTC2622	Dual 16-Bit/14-Bit/12-Bit Rail-to-Rail DACs in 8-Lead MSOP	$300\mu A$ per DAC, $2.5V$ to $5.5V$ Supply Range

2604fd